

# Maximum Margin Markov Networks

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This talk is based on the paper “Max-Margin Markov Networks”  
by B. Taskar, C. Guestrin and D. Koller [TGK03], NIPS 2003

# Structured Data

- ▶ Many Real-world tasks involve Sequential, Spatial, Structured data.
  - ▶ Eg. Hand-written character recognition: Image  $\rightarrow$  Word
  - ▶ NLP: Sentence  $\rightarrow$  Parse Tree
  - ▶ Bond prediction in Proteins: Amino acid Sequence  $\rightarrow$  Bond Structure
  - ▶ Terrain Segmentation: 3D Image  $\rightarrow$  Segmented Objects
- ▶ Common Characteristics:
  - ▶ Correlated Labels, Multi-label, Multi-class classification
  - ▶ Inference here is Global rather than Local

# Structured Classification

- ▶ Classification: Find a function that assigns a label to an arbitrary object
- ▶ Supervised Classification: Given a sequence of labelled examples independently chosen from an arbitrary distribution, find a function that will assign labels to unseen objects
- ▶ Structured Classification: To jointly classify different objects in the supervised setting

# Structured Classification and SVM

- ▶ SVM: Very effective classifier for a variety of applications
- ▶ SVM = Kernel + Generalization Bounds (Max-Margin)
- ▶ Kernel: Reduce arbitrary nonlinear classification in the input space to linear classification in the feature space.
- ▶ Generalization Bounds: Justification for Max-Margin
- ▶ SVM assign a single label to an object at a time, do not exploit correlation between labels.
- ▶ Running time of SVM: Polynomial in  $\#$  classes.
- ▶ To jointly classify objects with a joint label, an exponential number of classes required, so infeasible

# Markov Networks (MN) and Structured Classification

- ▶ Can express correlation between labels
- ▶ Can exploit problem structure
- ▶ Cannot handle high-dimensional feature spaces
- ▶ No strong generalization bounds

# Maximum-Margin Markov Networks ( $M^3N$ )

- ▶ Combines the Kernel and Max-Margin concepts of SVM with the ability of MN to handle structured data
- ▶ For structured classification,  $M^3N = SVM + MN$

<b>Characteristics</b>	<b>SVM</b>	<b>MN</b>	<b><math>M^3N</math></b>
High-dimensional Feature Space (Kernel)	+	-	+
Generalization Guarantees	+	-	+
Ability to deal with Structured Objects	-	+	+

# Structured Classification - Framework

- ▶ Task: Learn a function  $f : \mathcal{X} \rightarrow \mathcal{Y}$
- ▶  $S = \{(\mathbf{x}^{(i)}, \mathbf{y}^{(i)} = \mathbf{t}(\mathbf{x}^{(i)}))\}_{i=1}^m \sim D_{\mathcal{X} \times \mathcal{Y}}^m$
- ▶  $\mathcal{H}$ : A parameter family
- ▶ Classification function  $h \in H$
- ▶ Common choice:  $\mathcal{H}$  - linear family
- ▶ Given  $n$  basis functions  $\{f_j : \mathcal{X} \times \mathcal{Y} \rightarrow \mathbb{R}\}_{j=1, \dots, n}$
- ▶ A hypothesis  $h_w \in \mathcal{H}$  is defined by a set of  $n$  coefficients  $w_j \in \mathbb{R}$

$$\text{▶ } h_w(\mathbf{x}) = \arg \max_{\mathbf{y}} \sum_{i=1}^n w_i f_i(\mathbf{x}, \mathbf{y}) = \arg \max_{\mathbf{y}} \mathbf{w}^\top f(\mathbf{x}, \mathbf{y})$$

where  $f(\mathbf{x}, \mathbf{y})$  are features (=basic functions)

## Structured Classification - Framework (contd)

- ▶ Single-label case
  - ▶  $\mathcal{Y} = \{y_1, y_2, \dots, y_l\}$
- ▶ Our focus: Multi-Label case
  - ▶  $\mathcal{Y} = \mathcal{Y}_1 \times \dots \times \mathcal{Y}_k$
  - ▶  $\mathcal{Y}_i = \{y_1, y_2, \dots, y_l\}$
- ▶ Eg: OCR where  $\mathcal{Y}_i$ : A character,  $\mathcal{Y}$ : A full word
- ▶  $|\mathcal{Y}| = l^k \sim \exp(k)$
- ▶ Infeasible to
  - ▶ Represent basis functions  $f_j(\mathbf{x}, \mathbf{y})$
  - ▶ Compute  $\arg \max_{\mathbf{y}}$

# Probabilistic Graphical Model for Structured Classification

- ▶ Examples
  - ▶ Hidden Markov Model (HMM)
  - ▶ Conditional Random Field (CRF)
  - ▶ Markov Random Field (MRF) (aka Markov Network (MN))
- ▶ Here the model defines (directly or indirectly) a conditional distribution  $P(\mathcal{Y} | \mathcal{X})$
- ▶ Goal: Select the label  $\operatorname{argmax}_{\mathbf{y}} P(\mathbf{y} | \mathbf{x})$
- ▶ Advantage: Possible to exploit sparse label correlations
- ▶ Eg. OCR task using Markov Network
  - ▶  $\mathcal{Y}_i \perp\!\!\!\perp \mathcal{Y}_j | \mathcal{Y}_{i-1}, \mathcal{Y}_{i+1}, j \neq i-1, i+1$

# Encoding a Probability Structure in Markov Network

- ▶ Assumption: Pairwise interaction between labels
- ▶ MN:  $\mathcal{G} = (\mathcal{Y}, \mathcal{E})$ 
  - ▶ edge  $(i, j) \mapsto$  Potential  $\psi_{ij}(x, y_i, y_j)$
- ▶  $P(\mathbf{y} | \mathbf{x})$ : Joint Conditional Probability distribution encoded by the network
- ▶  $P(\mathbf{y} | \mathbf{x}) \propto \prod_{(i,j) \in E} \psi_{ij}(x, y_i, y_j)$
- ▶ MN: Compact Parametrization of a classifier
- ▶  $\mathcal{G} =$  Tree-structured network:
  - ▶  $\arg \max_y P(\mathbf{y} | \mathbf{x}) =$  Viterbi Algorithm
  - ▶ Efficient, even if there are an exponential number of labels
  - ▶ This is a great advantage of graphical models over SVM
- ▶ In general, Approximate Inference algorithm that exploit structure

# Markov Network Distribution - Log-Linear (LL) Model

- ▶ Belongs to the family of Generalized Linear Models
- ▶  $\psi_{ij}(x, y_i, y_j)$ : Network potential
- ▶  $f_k(x, y_i, y_j)$ : Basis functions,  $k = 1, \dots, n$
- ▶ MN can be parameterized by the Basis functions
- ▶ Assumption: All the edges in the graph denote the same type of interaction
- ▶  $f_k(\mathbf{x}, \mathbf{y}) = \sum_{(i,j) \in E} f_k(x, y_i, y_j)$  - features  $k = 1, \dots, n$
- ▶  $\log \psi_{ij}(x, y_i, y_j) = \sum_{k=1}^n w_k f_k(x, y_i, y_j)$
- ▶  $\psi_{ij}(x, y_i, y_j) = \exp\left[\sum_{k=1}^n w_k f_k(x, y_i, y_j)\right] = \exp[w^\top f(x, y_i, y_j)]$
- ▶  $w$  in LL model can be trained by Maximum Likelihood (ML) or Conditional Likelihood
- ▶ Alternative approach: To select  $w$  by maximizing the margin is the approach in  $M^3N$

# Loss function and Risk

- ▶ Statistical Learning Theory provides the justification for maximal margin criterion
- ▶ Maximum-margin minimizes the generalization error bound
- ▶ Loss function  $L : \mathcal{X} \times \mathcal{Y} \times \mathcal{Y} \rightarrow \mathbb{R}$
- ▶  $L(\mathbf{x}, \mathbf{y}, h(\mathbf{x}))$ : Loss in assigning  $h(\mathbf{x})$  to  $\mathbf{x}$  when the true label is  $\mathbf{y}$
- ▶  $L(\mathbf{x}, \mathbf{y}, \mathbf{y}) = 0$
- ▶ Goal: Minimize the total loss on the labels to predicted
- ▶  $R[h]$ : Expected risk in choosing classifier  $h$
- ▶  $R[h] := \int_{\mathcal{X} \times \mathcal{Y}} L(\mathbf{x}, \mathbf{y}, h(\mathbf{x})) d\mathcal{D}(\mathbf{x}, \mathbf{y})$
- ▶  $R[h]$  cannot be computed but can be approximated by the empirical risk  $R_{emp}[h]$  [Vapnik]
- ▶  $R_{emp}[h] := \frac{1}{n} \sum_{i=1}^n L(\mathbf{x}^{(i)}, \mathbf{t}^{(i)}, h(\mathbf{x}^{(i)}))$

# Generalization Error Bound

- ▶ Statistical Learning Theory informs the tradeoff between the choice of the model class (expressibility) and training error.
- ▶ Gives a theoretical bound on the generalization error of a classifier which is independent of the distribution  $\mathcal{D}$  (SVM)
- ▶ Generalization error independent of the dimension of the feature space
- ▶ Freedom from the 'curse of dimensionality' (SVM)
- ▶ SVM learning rooted in Statistical Learning Theory

# Margin-based Structured Classification

- ▶ SVM : Single label 2-classification
- ▶ (Single-label) m-classification extends 2-classification
- ▶  $\gamma$ : margin
- ▶  $\max \gamma$  s.t.  $\|\mathbf{w}\| \leq 1$ ;  $\mathbf{w}^\top \Delta \mathbf{f}_{\mathbf{x}}(\mathbf{y}) \geq \gamma$ ,  $\forall \mathbf{x} \in S$ ,  $\forall \mathbf{y} \neq \mathbf{t}(\mathbf{x})$ 
  - ▶ where  $\Delta \mathbf{f}_{\mathbf{x}}(\mathbf{y}) := \mathbf{f}(\mathbf{x}, \mathbf{t}(\mathbf{x})) - \mathbf{f}(\mathbf{x}, \mathbf{y})$
- ▶  $\arg \max_{\mathbf{y}} \mathbf{w}^\top \mathbf{f}(\mathbf{x}, \mathbf{y}) = \mathbf{t}(\mathbf{x})$  is a consequence of the above constraint

# Loss in Structured Problems

- ▶ Not a simple 0-1 loss
- ▶ 0-1 loss:  $I(\arg \max_{\mathbf{y}} \mathbf{w}^\top \mathbf{f}(\mathbf{x}, \mathbf{y}) = \mathbf{t}(\mathbf{x}))$
- ▶ Loss is a per-label loss aka Proportion of incorrect labels predicted
- ▶ Margin between  $\mathbf{t}(\mathbf{x})$  and  $\mathbf{y}$  scales linearly with the number of wrong labels in  $\mathbf{y}$ ,  $\Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y})$ :
  - ▶  $\max_{\gamma} \gamma$  s.t.  $\|\mathbf{w}\| \leq 1, \mathbf{w}^\top \Delta \mathbf{f}_{\mathbf{x}}(\mathbf{y}) \geq \gamma \Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y}), \forall \mathbf{x} \in S, \forall \mathbf{y}$
  - ▶  $\Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y}) := \sum_{i=1}^l \Delta \mathbf{t}_{\mathbf{x}}(y_i)$
  - ▶  $\Delta \mathbf{t}_{\mathbf{x}}(y_i) := I(y_i \neq (\mathbf{t}(\mathbf{x}))_i)$
- ▶ We tidy up the above by eliminating  $\gamma$  to get the Quadratic Program (QP)

# The QP Problem for Margin-based Structured Classification and its Dual

- ▶ QP:  $\min \frac{1}{2} \|w\|^2$  s.t.  $w^\top \Delta f_x(y) \geq \Delta t_x(y)$ ,  $\forall x \in S, \forall y$
- ▶ Introducing slack variables  $\xi_x$  to allow linearly inseparable data, we get the Primal (P) and Dual (D)
- ▶ (P):  $\min \frac{1}{2} \|w\|^2 + C \sum_x \xi_x$ ;  
s.t.  $w^\top \Delta f_x(y) \geq \Delta t_x(y) - \xi_x$ ,  $\forall x, \forall y$ .
- ▶ (D):  $\max \sum_{x,y} \alpha_x(y) \Delta t_x(y) - \frac{1}{2} \left\| \sum_{x,y} \alpha_x(y) \Delta f_x(y) \right\|^2$ ;  
s.t.  $\sum_y \alpha_x(y) = C$ ,  $\forall x$ ;  $\alpha_x(y) \geq 0$ ,  $\forall x, y$ .

## Difficulty in Solving Primal and Dual

- ▶ (P):  $\min \frac{1}{2} \|w\|^2 + C \sum_{\mathbf{x}} \xi_{\mathbf{x}};$   
 $s.t. \mathbf{w}^T \Delta \mathbf{f}_{\mathbf{x}}(\mathbf{y}) \geq \Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y}) - \xi_{\mathbf{x}}, \forall \mathbf{x}, \forall \mathbf{y}.$
- ▶ (D):  $\max \sum_{\mathbf{x}, \mathbf{y}} \alpha_{\mathbf{x}}(\mathbf{y}) \Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y}) - \frac{1}{2} \left\| \sum_{\mathbf{x}, \mathbf{y}} \alpha_{\mathbf{x}}(\mathbf{y}) \Delta \mathbf{f}_{\mathbf{x}}(\mathbf{y}) \right\|^2;$   
 $s.t. \sum_{\mathbf{y}} \alpha_{\mathbf{x}}(\mathbf{y}) = C, \forall \mathbf{x}; \alpha_{\mathbf{x}}(\mathbf{y}) \geq 0, \forall \mathbf{x}, \mathbf{y}.$
- ▶ # of constraints in (P) and # variables in (D) are both exponential in # labels
- ▶ Infeasible computation
- ▶ Can we get around it?

TGK03 give an affirmative answer in this paper !

## Key idea in the [TGK03] solution

- ▶ The variables  $\alpha_{\mathbf{x}}(y)$  in (D) can be interpreted as an unnormalized density function over  $y$  conditional on  $x$ :
  - ▶  $\sum_y \alpha_{\mathbf{x}}(y) = C, \alpha_{\mathbf{x}}(y) \geq 0$
- ▶ The dual objective is a function of
  - ▶  $\mathbb{E}[\Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y})]$  and  $\mathbb{E}[\Delta \mathbf{f}_{\mathbf{x}}(y)]$ , where  $\mathbb{E}$  expectation w.r.t  $\alpha_{\mathbf{x}}(y)$
- ▶  $\Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y}) := \sum_i \Delta \mathbf{t}_{\mathbf{x}}(y_i)$   
 $\Delta \mathbf{f}_{\mathbf{x}}(y) := \sum_{i,j} \Delta \mathbf{f}_{\mathbf{x}}(x_i, y_j)$   
are sums of functions over nodes and edges
- ▶ So only node and edge marginals of the measure  $\alpha_{\mathbf{x}}(y)$  needed to compute the above expectations
- ▶ Here the sparse correlations in the feature representations is used.

# Marginal Dual Variables (MDV)

- ▶ MDV  $\mu_{\mathbf{x}}(y_i, y_j)$  and  $\mu_{\mathbf{x}}(y_i)$  are defined here
- ▶  $\mu_{\mathbf{x}}(y_i, y_j) := \sum_{\mathbf{y} \sim [y_i, y_j]} \alpha_{\mathbf{x}} \mathbf{y}, \quad \forall (i, j) \in E, \forall y_i, y_j, \forall \mathbf{x};$
- ▶  $\mu_{\mathbf{x}}(y_i) := \sum_{\mathbf{y} \sim [y_i]} \alpha_{\mathbf{x}} \mathbf{y}, \quad \forall i, \forall y_i, \forall \mathbf{x};$
- ▶  $\mathbf{y} \sim [y_i, y_j]$  denote a full assignment  $\mathbf{y}$  consistent with partial assignments  $y_i, y_j$
- ▶ We now reformulate the QP (D) via MDV

## Reformulation of QP(D) via MDV

- ▶ The first term of the objective function in QP(D) Can be written in terms of MDV as follows

$$\begin{aligned}\text{▶ } \sum_{\mathbf{x}} \alpha_{\mathbf{x}}(\mathbf{y}) \Delta \mathbf{t}_{\mathbf{x}}(\mathbf{y}) &= \sum_{\mathbf{y}} \sum_i \alpha_{\mathbf{x}}(\mathbf{y}) \Delta \mathbf{t}_{\mathbf{x}}(y_i) \\ &= \sum_{i, y_i} \Delta \mathbf{t}_{\mathbf{x}}(y_i) \sum_{\mathbf{y} \sim [y_i]} \alpha_{\mathbf{x}}(\mathbf{y}) = \sum_{i, y_i} \mu_{\mathbf{x}}(y_i) \Delta \mathbf{t}_{\mathbf{x}}(y_i)\end{aligned}$$

- ▶ Similarly the second term of the objective function in QP(D) via the edge marginals  $\mu_{\mathbf{x}}(y_i, y_j)$

# Consistency Conditions to produce Equivalent QP

- ▶ To ensure that the MDV  $\mu_{\mathbf{x}}(y_i, y_j)$ ,  $\mu_{\mathbf{x}}(y_i)$  are marginals arising from a legal density  $\alpha(\mathbf{y})$ :
  - ▶  $\sum_{y_i} \mu_{\mathbf{x}}(y_i, y_j) = \mu_{\mathbf{x}}(y_j), \forall y_j, \forall (i, j) \in E, \forall \mathbf{x}$
- ▶ Now we can formulate the equivalent QP in MDV.

# Factored Dual QP Equivalent to Original QP(D)

$$\max_{\mathbf{x}} \sum_{i,y_i} \mu_{\mathbf{x}}(y_i) \Delta \mathbf{t}_{\mathbf{x}}(y_i) - \frac{1}{2} \sum_{\mathbf{x}, \hat{\mathbf{x}}} \sum_{\substack{(i,j) \\ y_i, y_j}} \sum_{\substack{(r,s) \\ y_r, y_s}} \mu_{\mathbf{x}}(y_i, y_j) \mu_{\hat{\mathbf{x}}}(y_r, y_s) \mathbf{f}_{\mathbf{x}}(y_i, y_j)^\top \mathbf{f}_{\hat{\mathbf{x}}}(y_r, y_s);$$

$$\text{s.t } \mu_{\mathbf{x}}(y_i, y_j) = \mu_{\mathbf{x}}(y_j); \mu_{\mathbf{x}}(y_i) = C; \mu_{\mathbf{x}}(y_i, y_j) \geq 0.$$

- ▶ The objective function here depends only on a polynomial number of MDV
- ▶ Kernels can be used as the basis functions enter as dot products
- ▶ The solution of the Factored Dual is

$$\blacktriangleright \mathbf{w} = \sum_{\mathbf{x}} \sum_{i,j} \sum_{y_i, y_j} \mu_{\mathbf{x}}(y_i, y_j) \Delta \mathbf{f}_{\mathbf{x}}(y_i, y_j)$$

# Conclusion

For Structured Data Classification,  $M^3N = SVM + MN$

## References

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